Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/657,165	YAMADA ET AL.	
Examiner	. Art Unit	
Brian Nash	3721	

OF A POLIFF						
SEARCHED						
Class	Subclass	Date	Examiner			
173	168,217	7/12/2005	BN			
227	156	7/12/2005	BN			
310	52,58,62,	7/13/2005	BN			
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
All clases (US patents only) text search - see attached history Invntr and IDS via EAST	7/14/2005	BN